

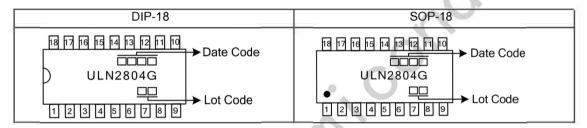
### **■ DESCRIPTION**

The **ULN2804** is a high voltage, high current Darlington array comprised of eight NPN Darlington pairs. The device features open-collector outputs with suppression diodes for inductive loads and is ideally suited for interfacing between low-level logic circuitry and high power loads. Typical loads including relays DC motors, filament lamps, LED displays, printer hammers and high power buffers.

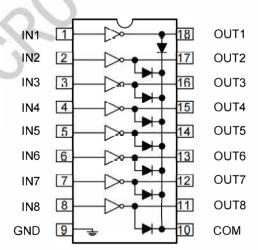
#### ■ FEATURE

- \* Eight Darlingtons with common emitters
- \* TTL, PMOS or CMOS Compatible inputs
- \* Peak output current to 500mA
- \* Output voltage to 50V
- \* Clamp diodes for transient suppression
- \* DIP-18 and SOP-18 packages

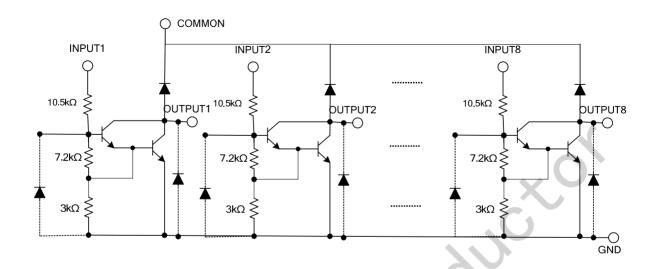
### ■ MARKING



### **■ PIN CONFIGURATIONS**



## ■ SCHEMATICS



## ■ ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	RATINGS	UNIT
Input Voltage	V <sub>IN</sub>	30	V
Output Voltage	V <sub>out</sub>	50	V
Collector Current – Continuous	Ic	500	mA
Base Current – Continuous	I <sub>B</sub>	25	mA
DIP-18	- P <sub>D</sub>	1.5	W
Power Dissipation SOP-18		0.95	V
Junction Temperature	$T_J$	+120	ô
Operating Ambient Temperature	T <sub>OPR</sub>	0 ~ +70	ç
Storage Temperature	T <sub>STG</sub>	-55 ~ +150	ô

Note Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied

# ■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Thermal resistance from junction to Ambient	DIP-18	0	60	°C /W
	SOP-18	$\theta_{ m JA}$	80	°C /W



## ■ ELECTRICAL CHARACTERISTICS (Ta = 25°C, unless otherwise specified.)

PARAMETER		SYMBOL	TEST FIGURE	TEST CONDITIONS		MIN	TYP	MAX	UNIT
Collector-Emitter Saturation Voltage		V <sub>CE(SAT)</sub>	1	I <sub>OUT</sub> =350mA, I <sub>IN</sub> =500μA			1.3	1.6	V
				I <sub>OUT</sub> =200mA, I <sub>IN</sub> =350μA			1.1	1.3	V
				I <sub>OUT</sub> =100mA,I <sub>IN</sub> =250μA			0.9	1.1	V
					I <sub>OUT</sub> =125mA			5.0	V
land Vallana			2	V <sub>CE</sub> =2.0V	I <sub>OUT</sub> =200mA			6.0	V
Input Voltage	$V_{IN(ON)}$	I <sub>OUT</sub> =275mA					7.0	V	
					I <sub>OUT</sub> =350mA			8.0	V
Clamp Diode Forward Voltage		$V_{F}$	3	I <sub>F</sub> =350mA			1.5	2.0	V
Output Leakage Current		, 4a		V <sub>OUT</sub> =50V,Ta=70°C				100	
		I <sub>CEX</sub>	<b>4</b> b	V <sub>OUT</sub> =50V,Ta=70°C,V <sub>IN</sub> =1.0V		4		500	μΑ
Input Current	ON	١,	5	V <sub>IN</sub> =5V		4	0.35	0.5	mΑ
	ON	I <sub>IN(ON)</sub>		V <sub>IN</sub> = 12V			1.0	1.45	mΑ
	OFF	I <sub>IN(OFF)</sub>	6	I <sub>OUT</sub> =500μA, Ta=70°C		50	100		μА
Clamp Diode Reverse Current		I <sub>R</sub>	7	V <sub>R</sub> =50V, Ta=25°C				50	μΑ
				V <sub>R</sub> =50V, Ta=70°C				100	μА
DC Current Gain		h <sub>FE</sub>		V <sub>OUT</sub> =2V, I <sub>OUT</sub> =350mA		1000			
Input Capacitance		C <sub>IN</sub>					15	25	pF
urn-On Delay		t <sub>ON</sub>	8				0.25	1	μS
Turn-Off Delay		t <sub>OFF</sub>	8				0.25	1	μS

### **■ TEST FIGURES**

Figure 1.

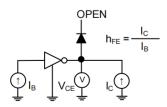


Figure 2.

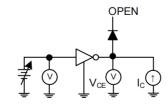


Figure 3.

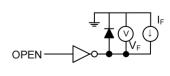


Figure 4a.

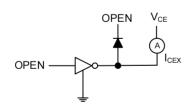


Figure 4b.

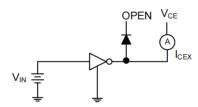


Figure 5.

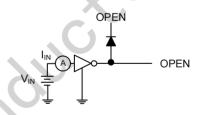


Figure 6.

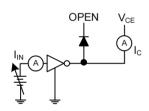


Figure 7.

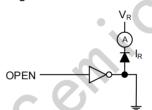
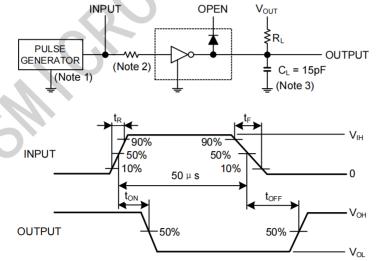


Figure 8.



Note1: Pulse width  $50\mu s$ , duty cycle 10%

Output impedance  $50\Omega$ ,  $t_R \le 5$ ns,  $t_F \le 10$ ns

Note2: R1: 0, V<sub>IH</sub>: 3V

Note3: C<sub>L</sub> includes probe and jig capacitance.



### TYPICAL CHARACTERISTICS

